

Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/761,667 – Conf. # 3419
				Filing Date	January 21, 2004
				First Named Inventor	Kenneth DONG
				Art Unit	2624
				Examiner Name	D. Rashid
Sheet	1	of	2	Attorney Docket Number	0291359.00126US2

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
	AA*	US-20010038713	11-08-2001	Kitagawa et al.	
	AB*	US-20020012454-A1	01-31-2002	Liu et al.	
	AC*	US-20020106114-A1	08-08-2002	Yan et al.	
	AD*	US-20030099409-A1	05-29-2003	Rowe	
	AE*	US-20030123713-A1	07-03-2003	Geng	
	AF*	US-20030169906-A1	09-11-2003	Gokturk et al.	
	AG*	US-20060204069	09-14-2006	Le Bras et al.	
	AH*	US-5,159,361	10-27-1992	Cambier et al.	
	AI*	US-5,742,291	04-21-1998	Palm	
	AJ*	US-5,825,936	10-20-1998	Clarke et al.	
	AK*	US-5,844,573	12-01-1998	Poggio et al.	
	AL*	US-5,898,438	04-27-1999	Stewart et al.	
	AM*	US-5,990,901	11-23-1999	Lawton et al.	
	AN*	US-6,094,199	07-25-2000	Turkiyyah et al.	
	AO*	US-6,226,418	05-01-2001	Miller et al.	
	AP*	US-6,249,600	06-19-2001	Reed et al.	
	AQ*	US-6,263,089	07-17-2001	Otsuka et al.	
	AR*	US-6,296,317	10-02-2001	Ollis et al.	
	AS*	US-6,320,578	11-20-2001	Shitani et al.	
	AT*	US-6,362,833-A1	03-26-2002	Trika	
	AU*	US-6,366,282	04-02-2002	Trika	
	AV*	US-6,381,346	04-30-2002	Eraslan	
	AW*	US-6,434,278	08-13-2002	Hashimoto	
	AX*	US-6,529,626	03-04-2003	Watanabe et al.	
	AY*	US-6,532,011	03-11-2003	Francini et al.	
	AZ*	US-6,556,196	04-29-2003	Blanz et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	BA	EP-1039417-A1	09-27-2000	Max-Planck-Gesellschaft		
	BB	EP-1143375	10-10-2001	NEC Corporation		
	BC	EP-1204069-A2	05-08-2002	NEC Research Institute, Inc.		
	BD	WO-01/63560	08-30-2001	Digimask Limited		

Examiner Signature		Date Considered	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO.: Those application(s) which are marked with an asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	CA	Weisstein, "Matrix Norm," December 22, 2003, http://mathworld.wolfram.com/MatrixNorm.html (2 pages)	
	CB	Weisstein, "Projective Geometry" December 22, 2003, http://mathworld.wolfram.com/ProjectiveGeometry.html (3 pages).	
	CC	Hsu, R-L and Jain, A. "Face Modeling For Recognition," Proceedings 2001 International Conference on Image Processing. ICIP 2001. Thessaloniki, Greece, Oct. 7-10, 2001, International Conference on Image Processing, New York, NY: IEEE, US, vol. 1 of 3. Conf. 8, 7 October 2001 (2001-10-07) pp. 693-696, XP010563858 ISBN: 0-7803-6725-1	
	CD	Tang, L-A, and Huang, T. S., "Face Recognition Using Synthesized Intermediate Views," Circuits and Systems, 1995, Proceedings of the 38th Midwest Symposium on Rio De Janeiro, Brazil 13-16 Aug. 1995, New York, NY USA, IEEE, US, pp. 1066-1069, XP010165313 ISBN: 0-7803-2792-4	
	CE	European Patent Office, Communication Pursuant to Article 96(2) EPC issued for EP04718062.5, 21 September 2007	
	CF	Eriksson et al., "Towards 3-dimensional face recognition," IEEE Cape Town, (September 28, 1999), pp. 401-406.	
	CG	International Search Report issued for PCT/US04/006604, dated September 2, 2004	
	CH	International Search Report issued for PCT/US04/006614, dated August 26, 2004	
	CI	International Search Report issued for PCT/US04/006827, dated August 26, 2004	
	CJ	Lanitis et al., "Toward Automatic Simulation of Aging Effects on Face Images," IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 24, No. 4 (April 2002), pp. 442-455	
	CK	Lee et al., "3-D deformable face model for pose determination and face synthesis," IEEE Computer Society, (September 27, 1999) pp. 260-265	
	CL	Lopez et al., "3D head pose computation from 2D images: templates versus features," IEEE Computer Society, Vol. 3 (October 23, 1995), pp. 599-602	
	CM	Pighin et al., "Synthesizing realistic facial expressions from photographs," Computer Graphics Conference Proceedings, (July 19, 1998), pp. 75-84	

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